

**Dual N-Channel Enhancement Mode Power MOSFET**

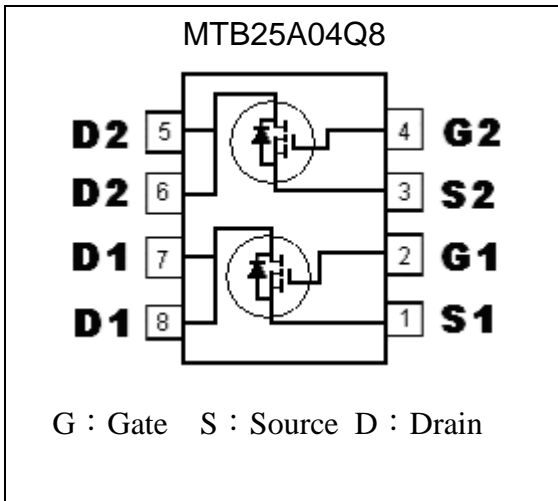
# MTB25A04Q8

<b>BV<sub>DSS</sub></b>	<b>40V</b>
<b>I<sub>D</sub>@ V<sub>GS</sub>=10V, T<sub>C</sub>=25°C</b>	<b>12A</b>
<b>R<sub>DS(on)</sub>@ V<sub>GS</sub>=10V, I<sub>D</sub>=8A</b>	<b>20mΩ (typ)</b>
<b>R<sub>DS(on)</sub>@ V<sub>GS</sub>=4.5V, I<sub>D</sub>=5A</b>	<b>26mΩ (typ)</b>

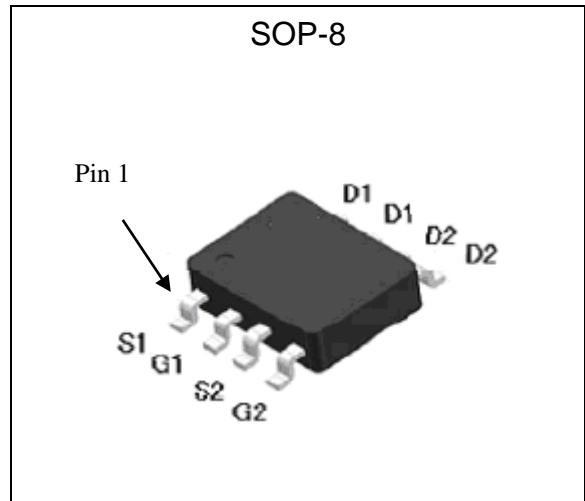
**Features**

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- Dual N-ch MOSFET package
- Pb-free lead plating & Halogen-free package

**Equivalent Circuit**

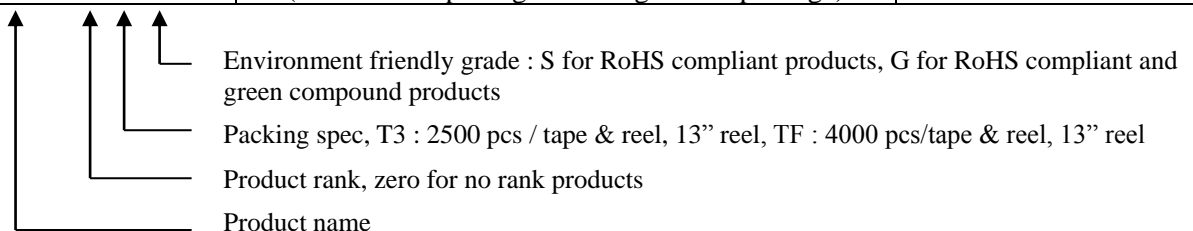


**Outline**



**Ordering Information**

Device	Package	Shipping
MTB25A04Q8-0-T3-G	SOP-8 (Pb-free lead plating and halogen-free package)	2500 pcs / tape & reel
MTB25A04Q8-0-TF-G	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / tape & reel





**Absolute Maximum Ratings** (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C	I <sub>D</sub>	12	A
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =100°C		8.5	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =25°C		8 (Note 2)	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =70°C		6.7 (Note 2)	
Pulsed Drain Current		I <sub>DM</sub>	
Single Pulse Avalanche Current @ L=0.1mH	I <sub>AS</sub>	12 (Note 4)	
Single Pulse Avalanche Energy @ L=1mH, I <sub>AS</sub> =6A, V <sub>DS</sub> =15V	E <sub>AS</sub>	18	mJ
Power Dissipation for Dual Operation	P <sub>D</sub>	3	W
Power Dissipation for Single Operation		2.4 (Note 2)	
		1.2 (Note 3)	
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55~+175	°C

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R <sub>th,j-c</sub>	25	°C/W
Thermal Resistance, Junction-to-ambient, max	R <sub>th,j-a</sub>	62.5 (Note 2)	
		125 (Note 3)	

- Note : 1. Pulse width limited by maximum junction temperature  
 2. Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, pulse width≤10s.  
 3. Surface mounted on minimum copper pad, pulse width≤10s.  
 4. 100% tested by conditions of L=0.1mH, I<sub>AS</sub>=6A, V<sub>GS</sub>=10V, V<sub>DD</sub>=15V.

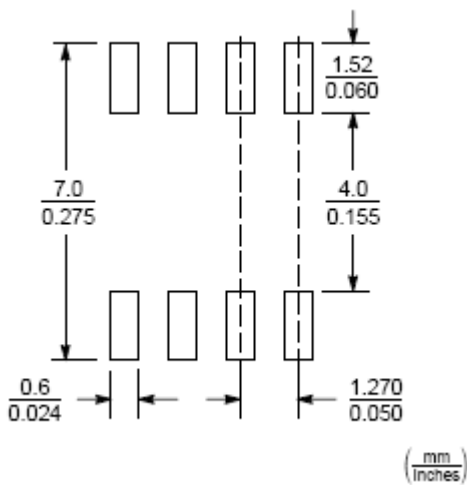
**Characteristics (T<sub>j</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	40	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	1.0	-	2.5		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub> *1	-	10	-	S	V <sub>DS</sub> = 5V, I <sub>D</sub> =8A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> = 32V, V <sub>GS</sub> = 0V
	-	-	25		V <sub>DS</sub> = 32V, V <sub>GS</sub> = 0V, T <sub>j</sub> =125°C
R <sub>DS(ON)</sub> *1	-	20	25	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> =8A
	-	26	35		V <sub>GS</sub> = 4.5V, I <sub>D</sub> =5A
<b>Dynamic</b>					
Q <sub>g</sub> (V <sub>GS</sub> =10V) *1, 2	-	9	18	nC	V <sub>DS</sub> =20V, I <sub>D</sub> =8A, V <sub>GS</sub> =10V
Q <sub>g</sub> (V <sub>GS</sub> =4.5V) *1, 2	-	5.5	8		
Q <sub>gs</sub> *1, 2	-	1.8	-		
Q <sub>gd</sub> *1, 2	-	2.5	-		

$t_{d(ON)}$ *1, 2	-	7	-	ns	$V_{DS}=20V, I_D=1A, V_{GS}=10V,$ $R_G=6\Omega$
$t_r$ *1, 2	-	5	-		
$t_{d(OFF)}$ *1, 2	-	21	-		
$t_f$ *1, 2	-	8	-		
$C_{iss}$	-	640	-	pF	$V_{GS}=0V, V_{DS}=20V, f=1MHz$
$C_{oss}$	-	51	-		
$C_{rss}$	-	45	-		
<b>Source-Drain Diode</b>					
$I_S$ *1	-	-	8	A	
$I_{SM}$ *3	-	-	24		
$V_{SD}$ *1	-	0.73	1.2	V	$I_S=1A, V_{GS}=0V$

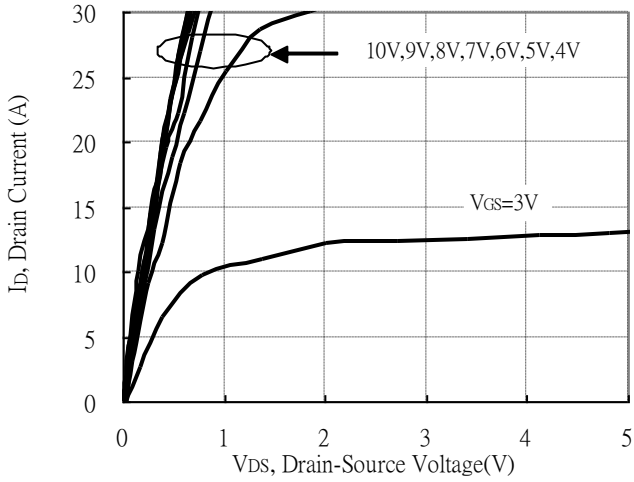
Note : \*1.Pulse Test : Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$   
 \*2.Independent of operating temperature  
 \*3.Pulse width limited by maximum junction temperature.

### Recommended Soldering Footprint

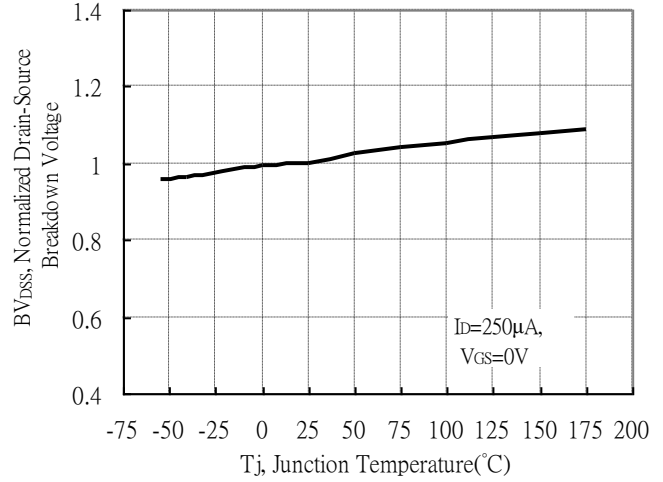


## Typical Characteristics

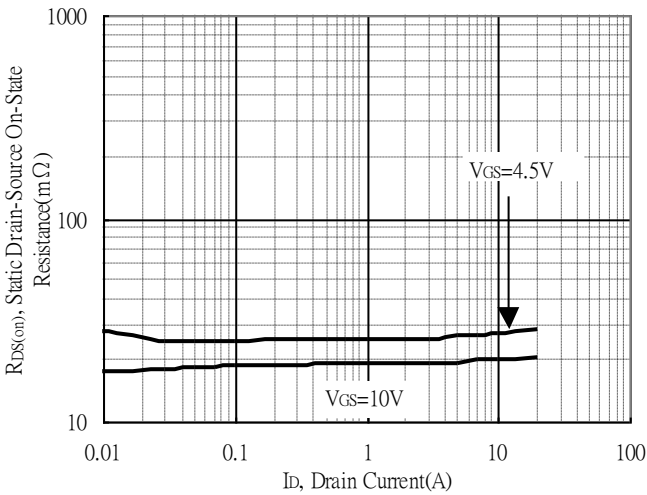
Typical Output Characteristics



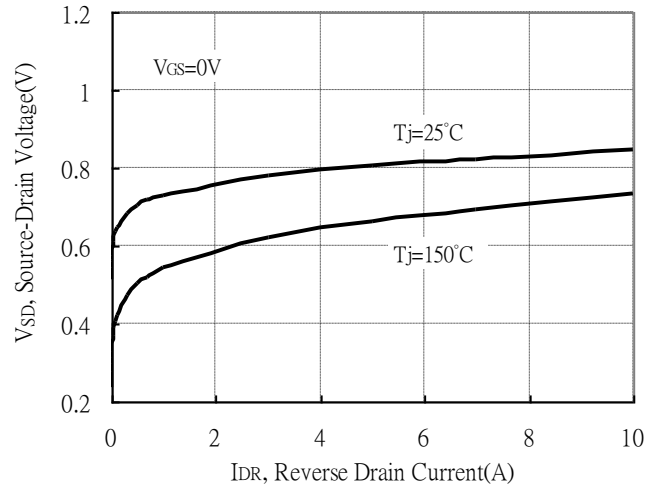
Brekdown Voltage vs Ambient Temperature



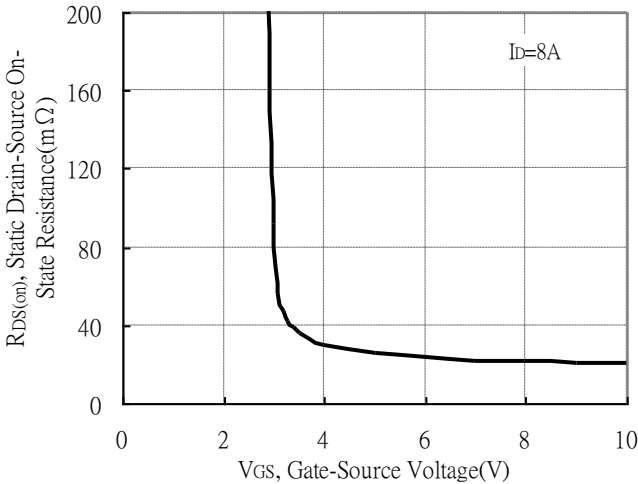
Static Drain-Source On-State resistance vs Drain Current



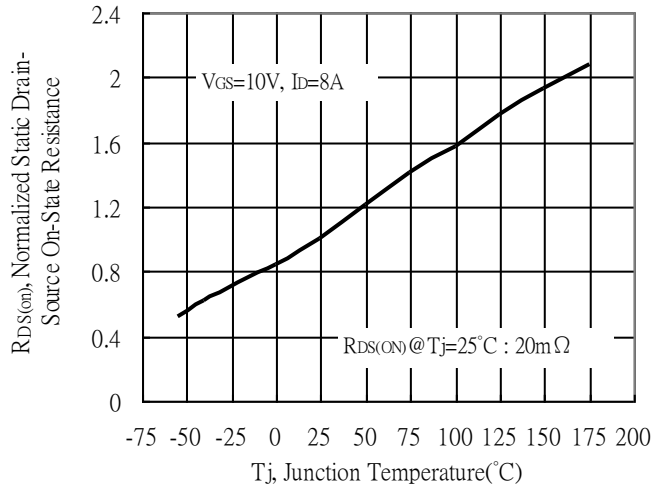
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

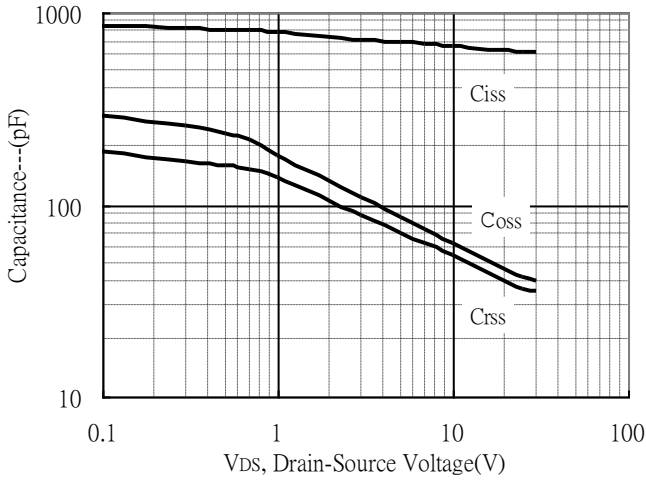


Drain-Source On-State Resistance vs Junction Temperature

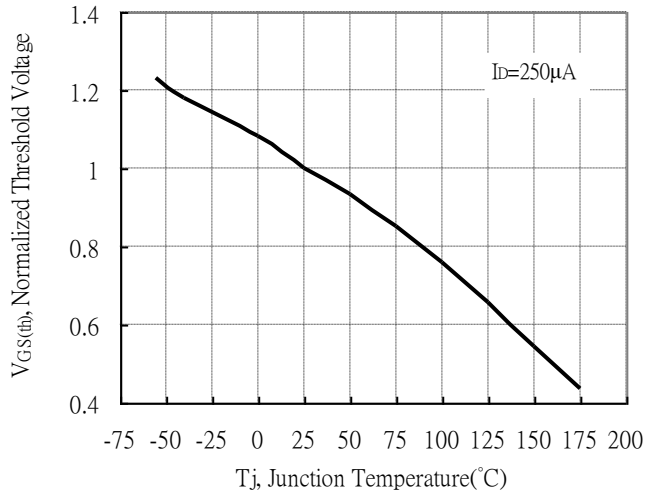


**Typical Characteristics(Cont.)**

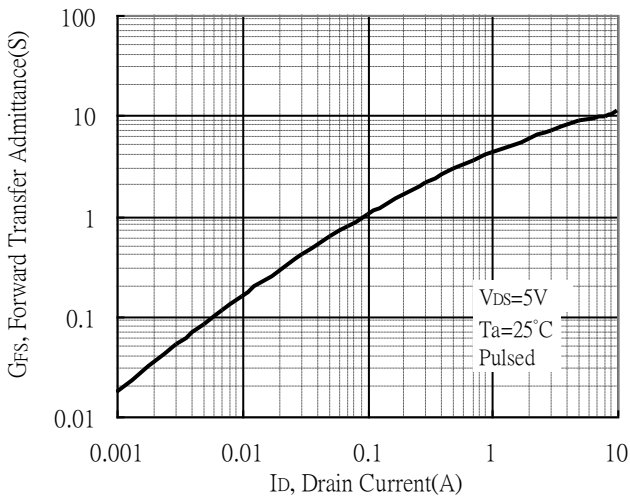
Capacitance vs Drain-to-Source Voltage



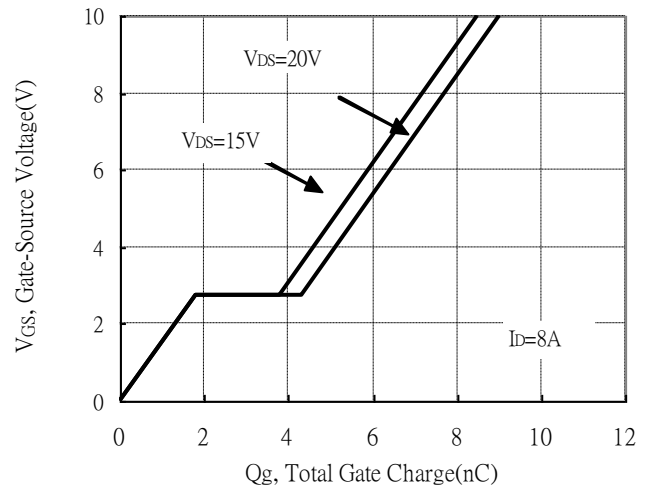
Threshold Voltage vs Junction Temperature



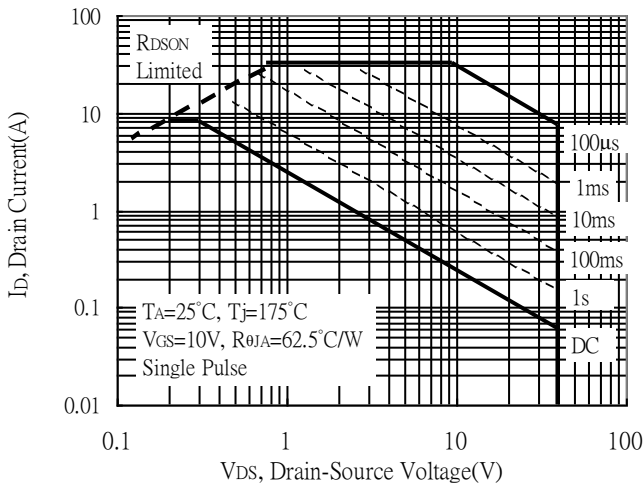
Forward Transfer Admittance vs Drain Current



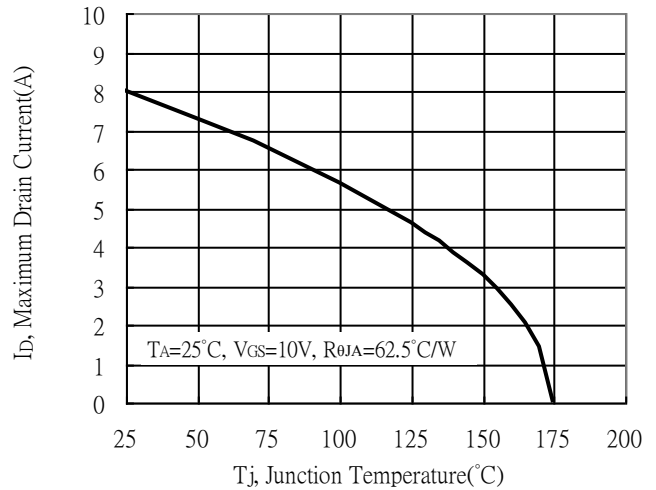
Gate Charge Characteristics



Maximum Safe Operating Area



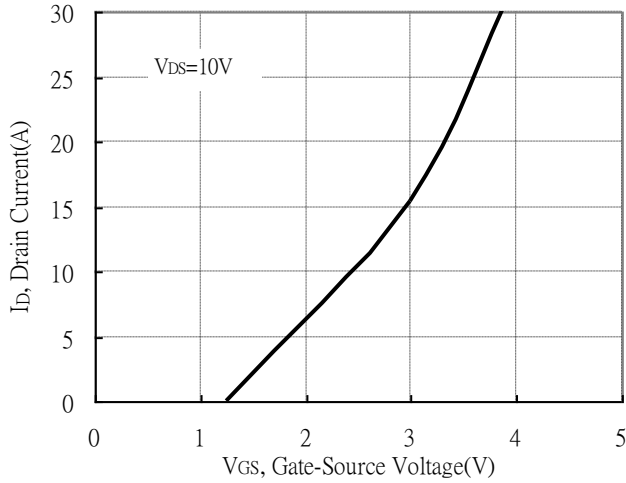
Maximum Drain Current vs Junction Temperature



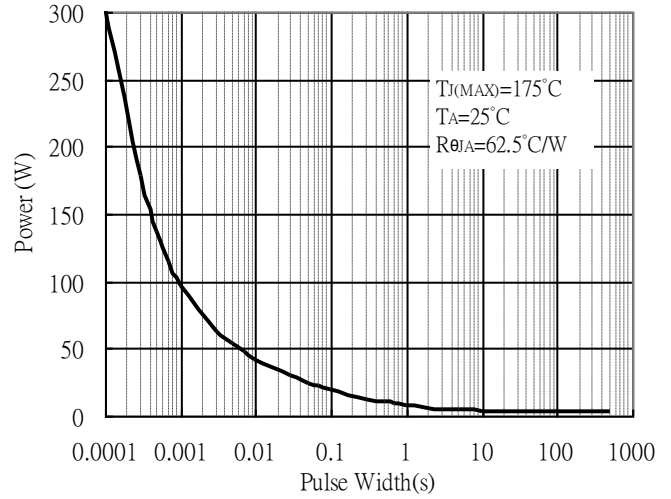


### Typical Characteristics(Cont.)

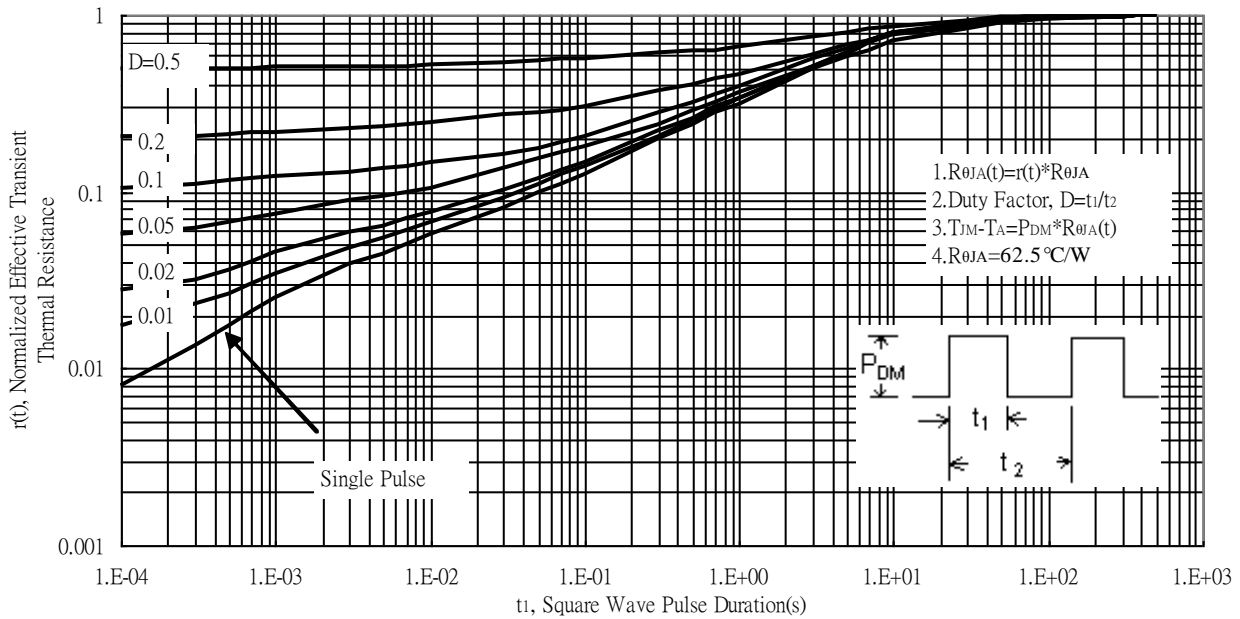
Typical Transfer Characteristics



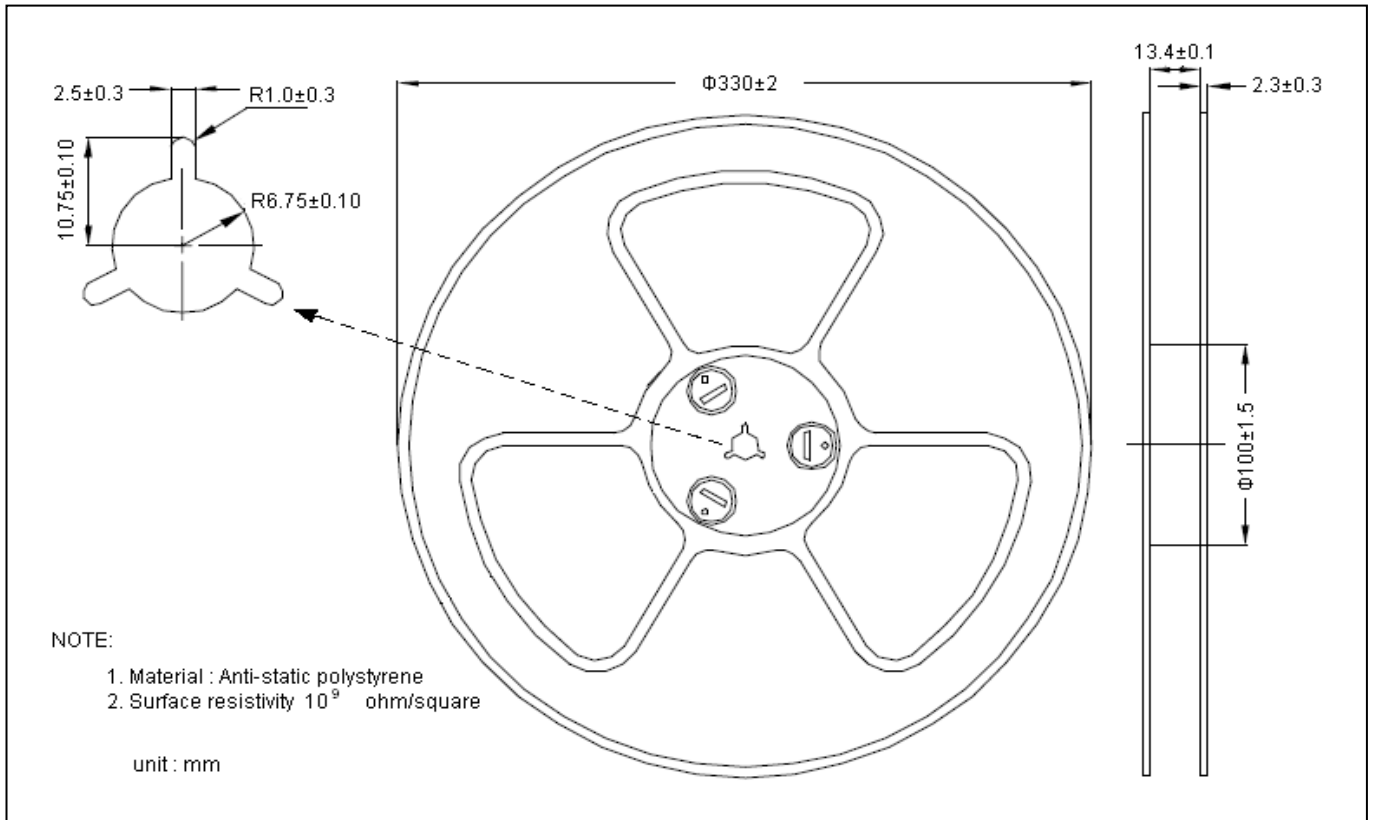
Single Pulse Maximum Power Dissipation



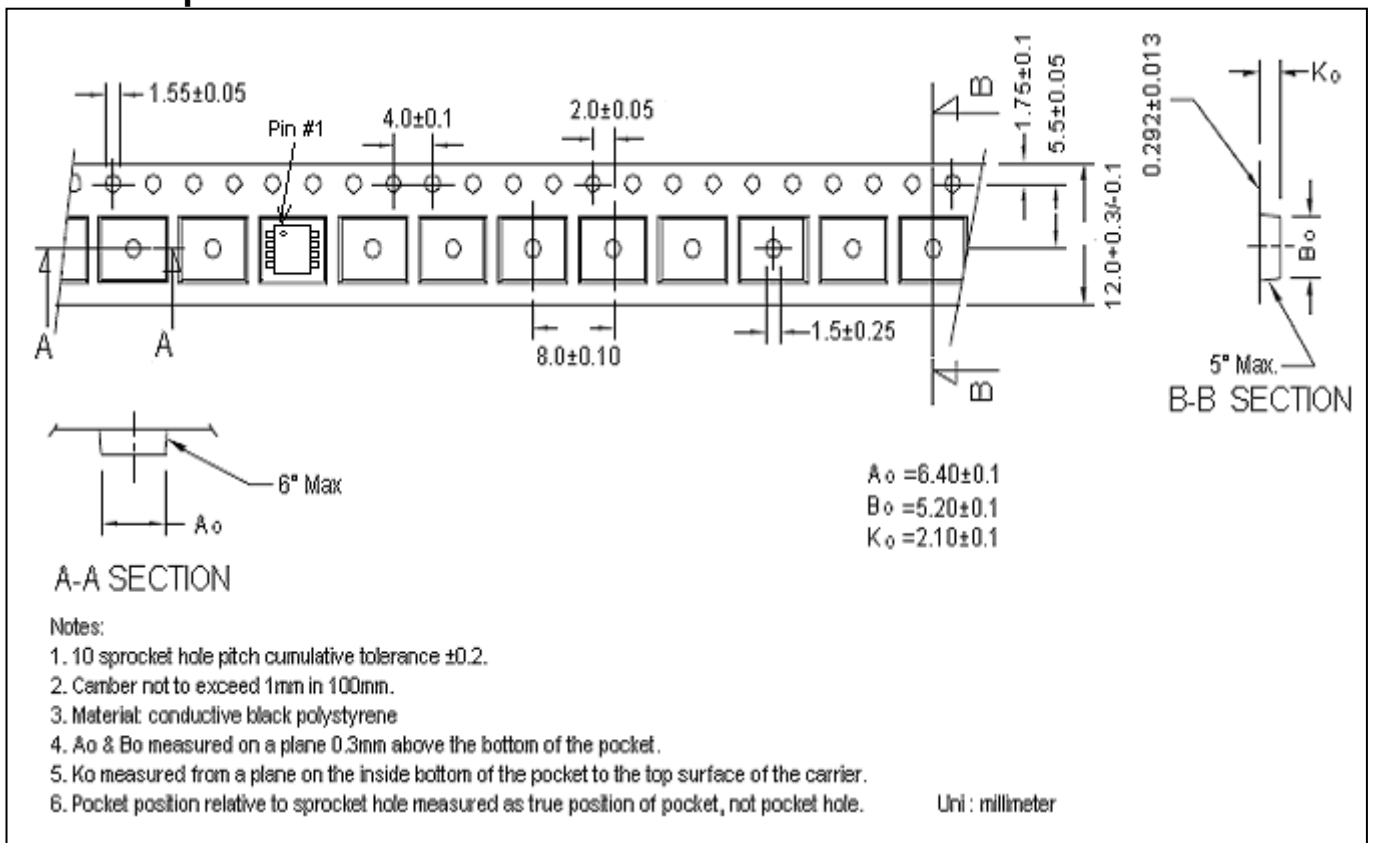
Transient Thermal Response Curves



**Reel Dimension**



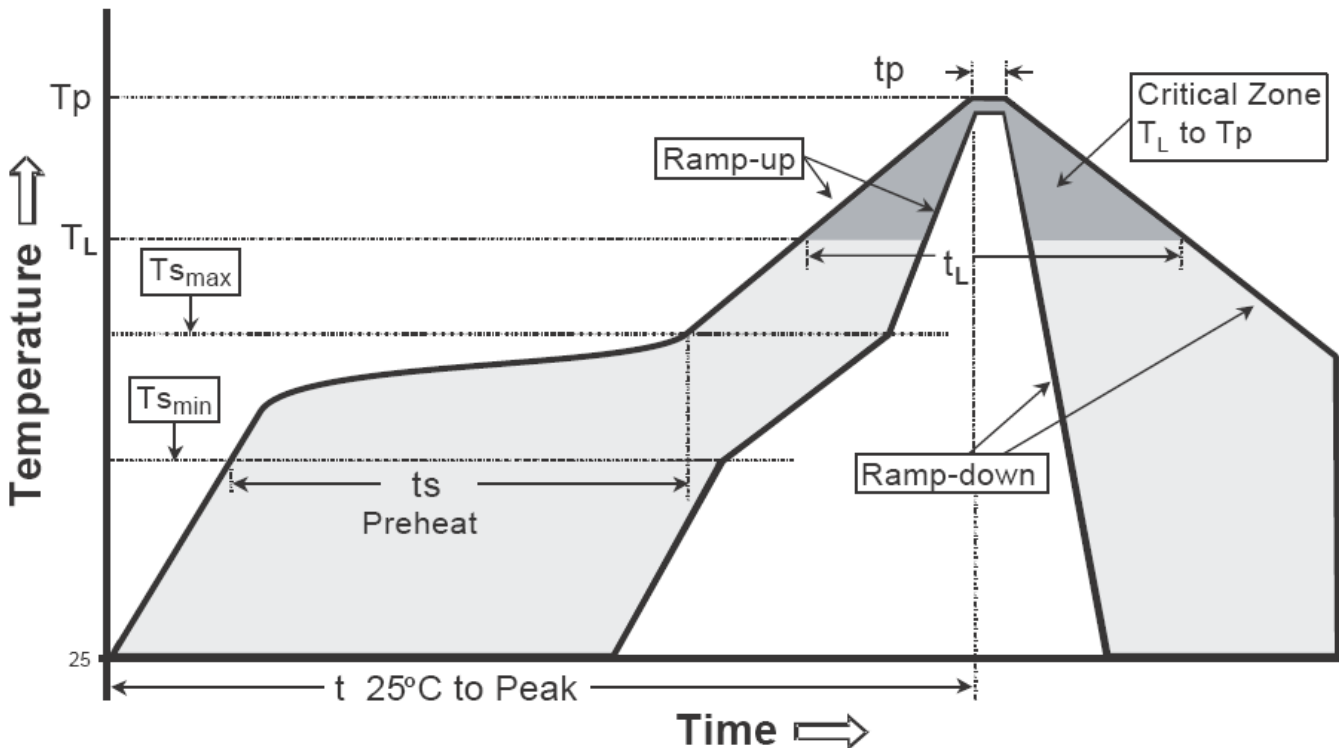
**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

**Recommended temperature profile for IR reflow**

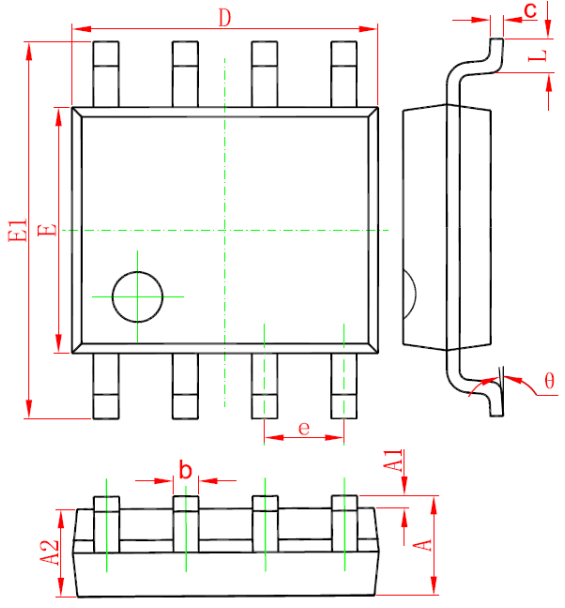


Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>p</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

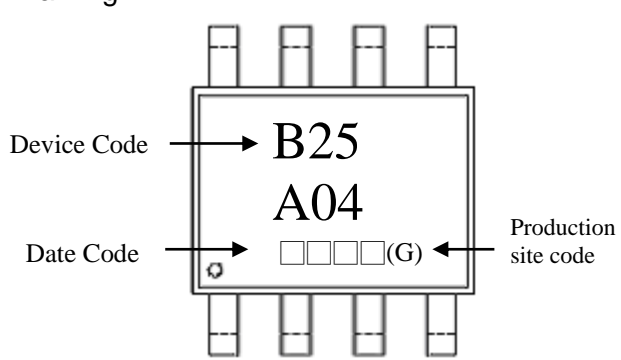
Note : All temperatures refer to topside of the package, measured on the package body surface.



**SOP-8 Dimension**



**Marking:**



Device Code → **B25**

Date Code → **A04** → Production site code

Date Code (counting from left to right) :

1<sup>st</sup> code : year code, the last digit of Christian year

2<sup>nd</sup> code : month code, Jan→A, Feb→B, Mar→C, Apr→D  
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,  
 Oct→K, Nov→L, Dec→M

3<sup>rd</sup> and 4<sup>th</sup> codes : production serial number, 01~99

Production site code : blank→ JCET, G →GEM

**8-Lead SOP-8 Plastic Package**  
 CYStek Package Code: Q8

\*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					

**Notes:** 1.Controlling dimension: millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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